



PolarHV[™] HiPerFET IXFP 3N50PM Power MOSFET

(Electrically Isolated Tab)

N-Channel Enhancement Mode Avalanche Rated Fast Intrinsic Diode



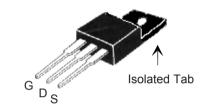
Symbol	Test Conditions	Maximum R	atings
V _{DSS} V _{DGR}	T_J = 25° C to 150° C T_J = 25° C to 150° C; R_{GS} = 1 M Ω	500 500	V V
V _{GSS} V _{GSM}	Continuous Transient	± 30 ± 40	V
 _{D25} _{DM}	$T_{\rm C}$ = 25° C $T_{\rm C}$ = 25° C, pulse width limited by $T_{\rm JM}$	2.7 8	A A
I _{AR} E _{AR} E _{AS}	T _c = 25° C T _c = 25° C T _c = 25° C	3 10 100	A mJ mJ
dv/dt	$I_{S} \leq I_{DM}, \text{ di/dt} \leq 100 \text{ A/}\mu\text{s}, V_{DD} \leq V_{DSS},$ $T_{J} \leq 150^{\circ}\text{ C}, R_{G} = 50 \Omega$	10	V/ns
P_{D}	T _C =25°C	36	W
T _J T _{JM} T _{stg}		-55 +150 150 -55 +150	°C °C °C
T _L	1.6 mm (0.062 in.) from case for 10 s Plastic body for 10 s	300 260	°C

M_d Mounting torque 1.13/10 Nm/lb.in. Weight 4 g Symbol Test Conditions (T_J = 25° C, unless otherwise specified) Min. Typ. Max.

Symbol Test Conditions $(T_J = 25^{\circ} C, \text{ unless otherwise specified})$			Characteristic Values Min. Typ. Max.			
BV _{DSS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		500			V
$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		3.0		5.5	V
I _{GSS}	$V_{GS} = \pm 30 \ V_{DC}, \ V_{DS} = 0$				±100	nA
I _{DSS}	$V_{DS} = V_{DSS}$ $V_{GS} = 0 V$	T _J = 125° C			5 200	μ Α μ Α
R _{DS(on)}	V _{GS} = 10 V, I _D = 1.8 A Note 1				2.0	Ω

$egin{array}{lll} {\sf V}_{\sf DSS} &=& 500 & {\sf V} \\ {\sf I}_{\sf D25} &=& 2.7 & {\sf A} \\ {\sf R}_{\sf DS(on)} &\leq& 2.0 & {\Omega} \\ {\sf t}_{\sf rr} &\leq& 200 & {\sf ns} \\ \end{array}$

OVERMOLDED TO-220 (IXTP...M) OUTLINE



G = Gate D = Drain S = Source

Features

- Plastic overmolded tab for electrical isolation
- Fast intrinsic diode
- International standard package
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
 - easy to drive and to protect

Advantages

- Easy to mount
- Space savings
- High power density

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Symbo	Test Conditions $ (T_{_{J}} = 25^{\circ} \text{C, unles} $ Min.		ristic Values rise specified) Max.
g _{fs}	V_{DS} = 10 V; I_{D} = 1.8 A, Note 1	3.5	S
C _{iss})	409	pF
C _{oss}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	48	pF
\mathbf{C}_{rss}	J	6.1	pF
t _{d(on)}		25	ns
t,	$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_{D} = 3.6 \text{ A}$	28	ns
$\mathbf{t}_{d(off)}$	$R_{\rm G} = 50 \ \Omega $ (External)	63	ns
t _f	J	29	ns
$\mathbf{Q}_{g(on)}$)	9.3	nC
Q_{gs}	$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_{D} = 1.8$	3.3	nC
\mathbf{Q}_{gd}	J	3.4	nC
R _{thJC}			3.5 °C/W

Source-Drain Diode

Characteristic Values (T. = 25° C unless otherwise specified)

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Symbo	ol Test Conditions Min.	Тур.	Max.	
Is	$V_{GS} = 0 V$		3.6	Α
I _{sm}	Repetitive		5	Α
V _{SD}	$I_F = I_S$, $V_{GS} = 0$ V, Note 1		1.5	V
\mathbf{t}_{rr} \mathbf{Q}_{RM} \mathbf{I}_{RM}	$\begin{cases} I_F = 3.6 \text{ A, -di/dt} = 100 \text{ A/}\mu\text{s,} \\ V_R = 100 \text{ V, V}_{GS} = 0 \text{ V} \end{cases}$	0.1 0.5	200	ns μC Α

ISOLATED TO-220 (IXTP...M)

Terminals: 1 - Gate 2 - Drain (Collector) 3 - Source (Emitter)

MYZ	INCHES		MILLIMETERS		
21M	MIN	MAX	MIN	MAX	
Α	.177	.193	4.50	4.90	
A1	.092	.108	2.34	2.74	
A2	.101	.117	2.56	2.96	
b	.028	.035	0.70	0.90	
b1	.050	.058	1.27	1.47	
С	.018	.024	0.45	0.60	
D	.617	.633	15.67	16.07	
E	.392	.408	9.96	10.36	
е	.100 BSC		2.54 BSC		
Н	.255	.271	6.48	6.88	
L	.499	.523	12.68	13.28	
L1	.119	.135	3.03	3.43	
ØΡ	.121	.129	3.08	3.28	
Q	.126	.134	3.20	3.40	

Notes:

- 1) Pulse test, t \leq 300 μ s, duty cycle d \leq 2 %
- 2) Test current I_{τ} = 2.5 A

PRELIMINARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from data gathered during objective characterizations of preliminary engineering lots; but also may yet contain some information supplied during a pre-production design evaluation. IXYS reserves the right to change limits, test conditions, and dimensions without notice.